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[JP/JP]; c/o CANON KABUSHIKI KAISHA, 3-30-2, Shimomaruko, Ohta-ku, Tokyo 1468501.

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(74) Agents: **OKABE, Masao** et al.; No. 602, Fuji Bldg., 2-3, Marunouchi 3-chome, Chiyoda-ku, Tokyo 1000005 (JP).

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(71) Applicant (*for all designated States except US*): **CANON KABUSHIKI KAISHA** [JP/JP]; 3-30-2, Shimomaruko, Ohta-ku Tokyo, 1468501 (JP).

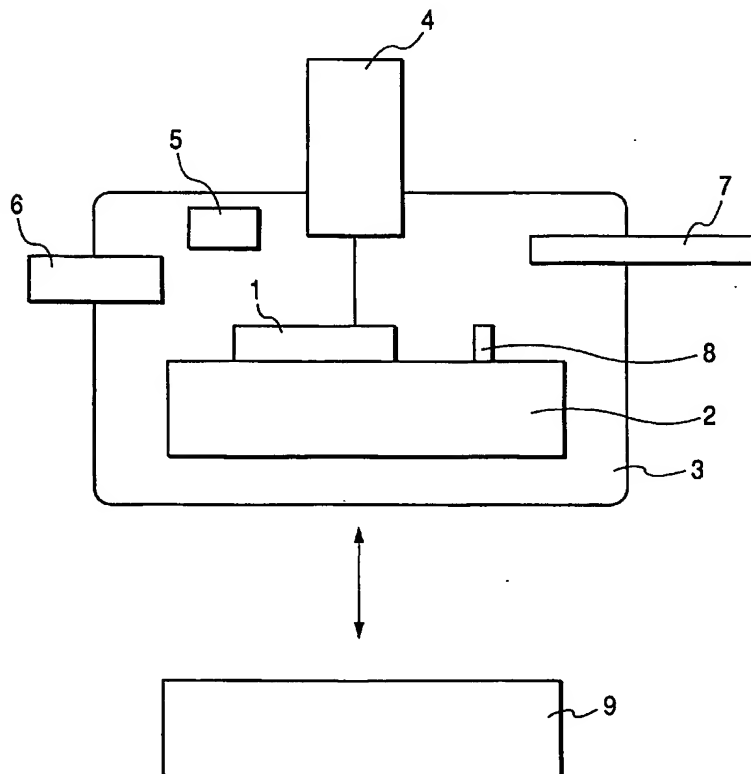
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(72) Inventor; and

(75) Inventor/Applicant (*for US only*): **MOTOI, Taiko**

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(54) Title: PROBE-HOLDING APPARATUS, SAMPLE-OBTAINING APPARATUS, SAMPLE-PROCESSING APPARATUS, SAMPLE-PROCESSING METHOD AND SAMPLE-EVALUATING METHOD



(57) Abstract: The present invention provides an apparatus for conveying or preparing a specimen for observation, which comprises a probe for conveying a specimen, and temperature control means for controlling the temperature of the sample and the probe whereby the sample does not change during processing or conveyance.



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